

**AUIRFS3004-7P** 

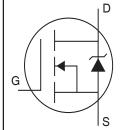
HEXFET® Power MOSFET

#### **Features**

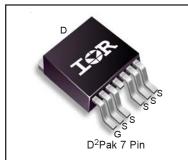
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- · Lead-Free, RoHS Compliant
- Automotive Qualified \*

### **Description**

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications such as Electric Power Steering, Battery Switch, SMPS and other heavy loads.



V <sub>DSS</sub>	40V
R <sub>DS(on)</sub> typ.	$0.90m\Omega$
max.	<b>1.25m</b> $\Omega$
I <sub>D (Silicon Limited)</sub>	400A①
I <sub>D (Package Limited)</sub>	240A



G	D	S
Gate	Drain	Source

Dana mant mumban	Standard Pack			Commisto Post Number
Base part number	number Package Type Form		Quantity	Complete Part Number
AL IIDE00004 7D	-2:	Tube	50	AUIRFS3004-7P
AUIRFS3004-7P	D <sup>2</sup> Pak 7 Pin	Tape and Reel Left	800	AUIRFS3004-7TRL

### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T<sub>A</sub>) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	400①	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	280①	_
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Wire Bond Limited)	240	A
I <sub>DM</sub>	Pulsed Drain Current ②	1610	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	380	W
	Linear Derating Factor	2.5	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally limited) ③	290	mJ
I <sub>AR</sub>	Avalanche Current ②	See Fig. 14, 15, 22a, 22b	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ②		mJ
dv/dt	Peak Diode Recovery ④	2.0	V/ns
T <sub>J</sub>	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	$\neg$

### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case 9 ®		0.40	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ®		40	

HEXFET® is a registered trademark of International Rectifier.

<sup>\*</sup>Qualification standards can be found at http://www.irf.com/



### Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.038		V/°C	Reference to 25°C, I <sub>D</sub> = 5mA <sup>②</sup>
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		0.90	1.25	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 195A ⑤
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
gfs	Forward Transconductance	1300			S	$V_{DS} = 10V, I_{D} = 195A$
$R_G$	Internal Gate Resistance		2.0		Ω	
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20	μΑ	$V_{DS} = 40V, V_{GS} = 0V$
				250		$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-100	Ī	V <sub>GS</sub> = -20V

### Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$\overline{Q_g}$	Total Gate Charge	_	160	240	nC	I <sub>D</sub> = 180A
$Q_{gs}$	Gate-to-Source Charge		42			$V_{DS} = 20V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		65			V <sub>GS</sub> = 10V ⑤
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )		95			$I_D = 180A, V_{DS} = 0V, V_{GS} = 10V$
$t_{d(on)}$	Turn-On Delay Time		23		ns	$V_{DD} = 26V$
t <sub>r</sub>	Rise Time		240			$I_D = 240A$
t <sub>d(off)</sub>	Turn-Off Delay Time		91			$R_G = 2.7\Omega$
t <sub>f</sub>	Fall Time		160			V <sub>GS</sub> = 10V ⑤
C <sub>iss</sub>	Input Capacitance		9130		рF	$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		2020			$V_{DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance		990			f = 1.0  MHz,  See Fig. 5
C <sub>oss</sub> eff. (ER)	Effective Output Capacitance (Energy Related) ⑦		2590			$V_{GS} = 0V$ , $V_{DS} = 0V$ to 32V $\odot$ , See Fig. 11
C <sub>oss</sub> eff. (TR)	Effective Output Capacitance (Time Related) ©		2650			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V $

#### **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			400①	Α	MOSFET symbol
	(Body Diode)					showing the
I <sub>SM</sub>	Pulsed Source Current			1610	Α	integral reverse
	(Body Diode) ②					p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 195A, V_{GS} = 0V $ §
t <sub>rr</sub>	Reverse Recovery Time		49		ns	$T_J = 25^{\circ}C$ $V_R = 34V$ ,
			51			$T_J = 125^{\circ}C$ $I_F = 240A$
Q <sub>rr</sub>	Reverse Recovery Charge		37		nC	$T_J = 25^{\circ}C$ di/dt = 100A/ $\mu$ s $\odot$
			41			$T_J = 125$ °C
I <sub>RRM</sub>	Reverse Recovery Current		3.2		Α	$T_J = 25^{\circ}C$
t <sub>on</sub>	Forward Turn-On Time	Intrins	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

#### Notes:

- ① Calculated continuous current based on maximum allowable junction ⑤ Pulse width ≤ 400µs; duty cycle ≤ 2%. temperature. Bond wire current limit is 240A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature.
- 3 Limited by  $T_{Jmax}$ , starting  $T_J = 25$ °C, L = 0.01mH  $R_G = 25\Omega$ ,  $I_{AS} = 240A$ ,  $V_{GS} = 10V$ . Part not recommended for use above this value.
- $\textcircled{4} \quad I_{SD} \leq 240 A, \; di/dt \leq 740 A/\mu s, \; V_{DD} \leq V_{(BR)DSS}, \; T_{J} \leq 175 ^{\circ} C.$
- © Coss eff. (TR) is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- $\ensuremath{\mathfrak{D}}$  Coss eff. (ER) is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ® When mounted on 1" square PCB (FR-4 or G-10 Material). For recom mended footprint and soldering techniques refer to application note #AN-994.
- $\ \, \mbox{\Large \ensuremath{\mathfrak{G}}} \ \, R_{\theta} \, \mbox{is measured at $T_J$ approximately $90^{\circ}$C} \, .$
- 1 R<sub> $\theta$ JC</sub> value shown is at time zero.



# **Qualification Information**<sup>†</sup>

			Automotive (per AEC-Q101) ††			
Qualification	Level	Industrial and C	Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
		D <sup>2</sup> PAK - 7 Pin	D <sup>2</sup> PAK - 7 Pin MSL1			
	Machine Model	Class M4 (+/- 800V) <sup>†††</sup>				
			AEC-Q101-002			
	Human Body Model	Class H3A (+/- 6000V) <sup>†††</sup>				
ESD			AEC-Q101-001			
Charged Device Model		Class C5 (+/- 2000V) <sup>†††</sup>				
			AEC-Q101-005			
RoHS Complia	ant	Yes				

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: <a href="http://www.irf.com/">http://www.irf.com/</a>

<sup>††</sup> Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.

<sup>†††</sup> Highest passing voltage.



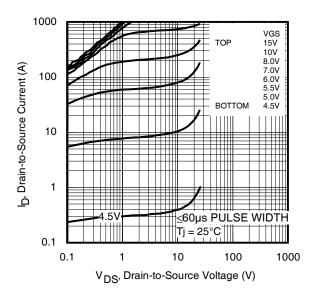


Fig 1. Typical Output Characteristics

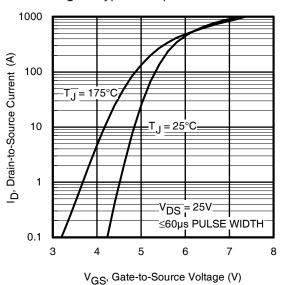


Fig 3. Typical Transfer Characteristics

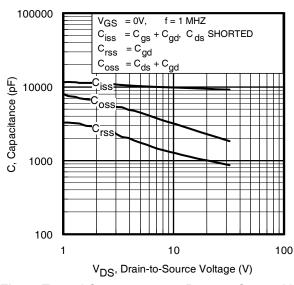


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

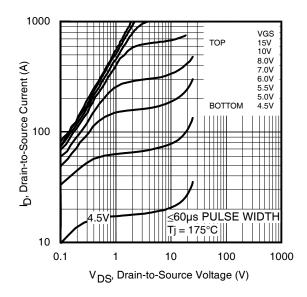


Fig 2. Typical Output Characteristics

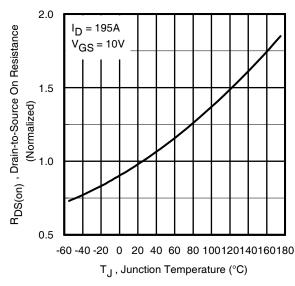


Fig 4. Normalized On-Resistance vs. Temperature

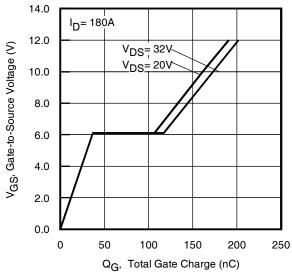


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



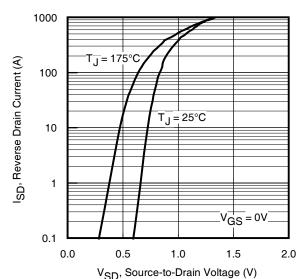
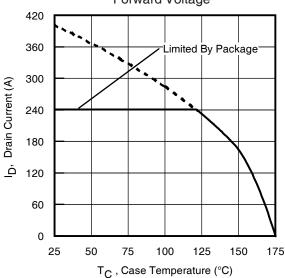


Fig 7. Typical Source-Drain Diode Forward Voltage



**Fig 9.** Maximum Drain Current vs. Case Temperature

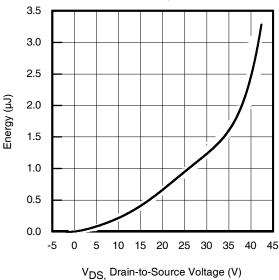


Fig 11. Typical C<sub>OSS</sub> Stored Energy

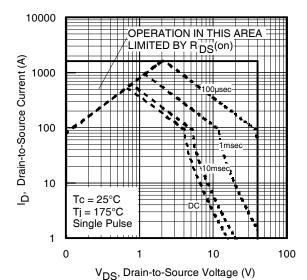


Fig 8. Maximum Safe Operating Area

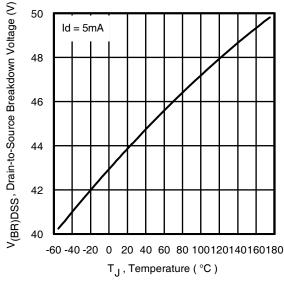


Fig 10. Drain-to-Source Breakdown Voltage

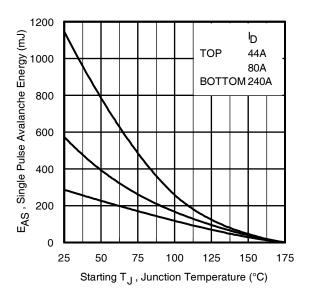


Fig 12. Maximum Avalanche Energy vs. DrainCurrent



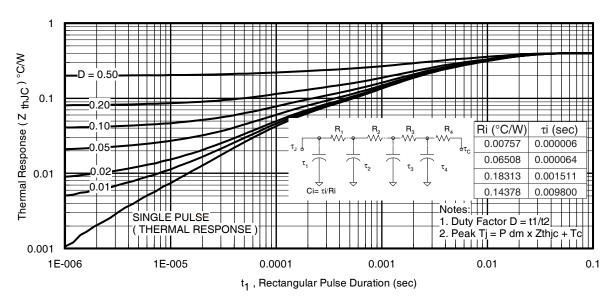


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

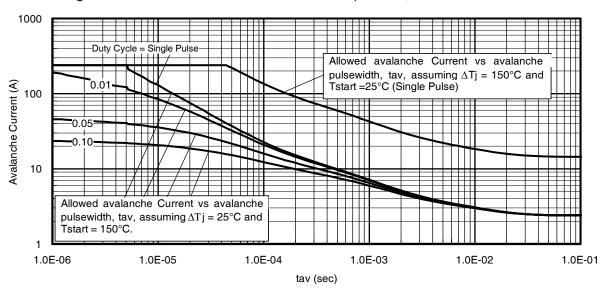


Fig 14. Typical Avalanche Current vs. Pulsewidth

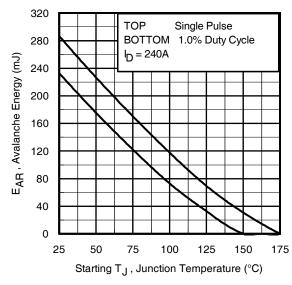


Fig 15. Maximum Avalanche Energy vs. Temperature

# Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
  - Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT<sub>imax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4.  $P_{D (ave)}$  = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. l<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).
- t<sub>av =</sub> Average time in avalanche.
- D = Duty cycle in avalanche =  $t_{av} \cdot f$
- $Z_{th,JC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$



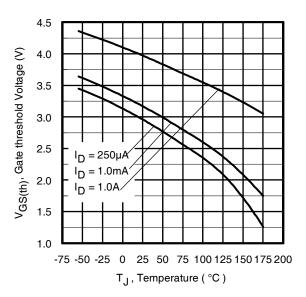


Fig 16. Threshold Voltage vs. Temperature

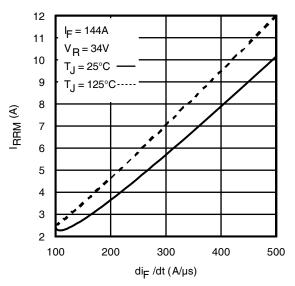


Fig. 18 - Typical Recovery Current vs. di<sub>f</sub>/dt

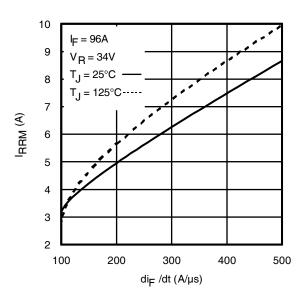


Fig. 17 - Typical Recovery Current vs. di<sub>f</sub>/dt

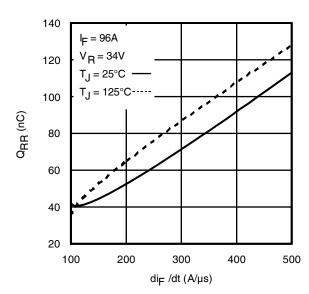


Fig. 19 - Typical Stored Charge vs. dif/dt

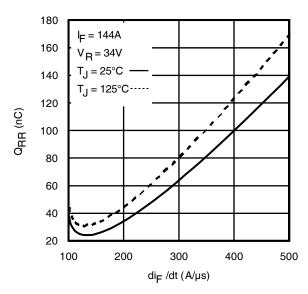


Fig. 20 - Typical Stored Charge vs. dif/dt



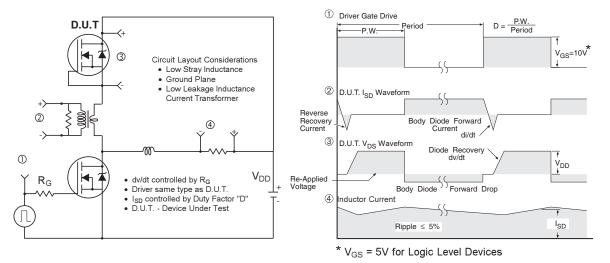


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

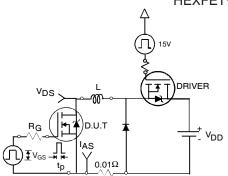


Fig 22a. Unclamped Inductive Test Circuit

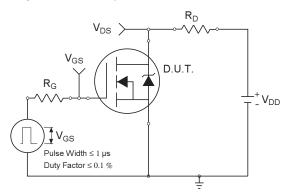


Fig 23a. Switching Time Test Circuit

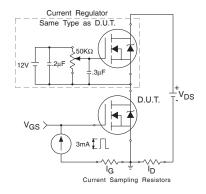


Fig 24a. Gate Charge Test Circuit

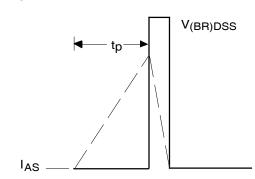


Fig 22b. Unclamped Inductive Waveforms

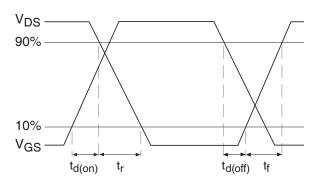


Fig 23b. Switching Time Waveforms

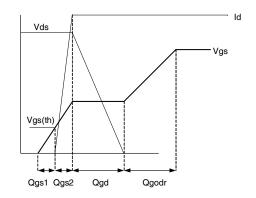
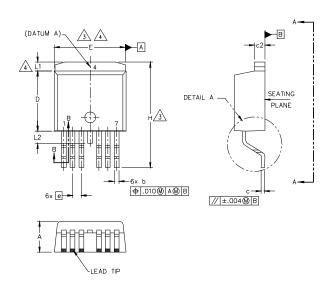


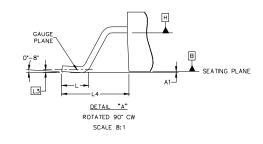
Fig 24b. Gate Charge Waveform

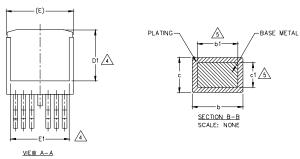


# D<sup>2</sup>Pak - 7 Pin Package Outline

Dimensions are shown in millimeters (inches)







S Y M		N			
M B O L	MILLIMETERS		INC	HES	O T E S
L	MIN.	MAX.	MIN.	MAX.	S
Α	4,06	4.83	.160	.190	
A1	-	0.254	_	.010	
b	0.51	0.99	.020	.036	
ь1	0.51	0.89	.020	.032	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270		4
E	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245		4
е	1.27	BSC	.050	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	-	1.68	-	.066	4
L2	_	1.78	_	.070	
L3	0.25	BSC	.010	BSC	
L4	4.78	5.28	.188	.208	

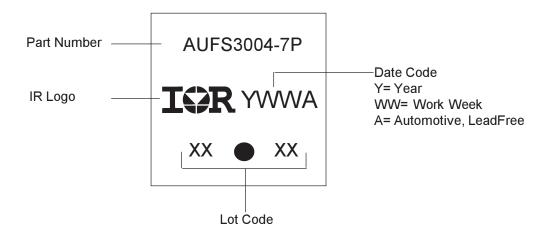
#### NOTES:

- 1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263CB.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



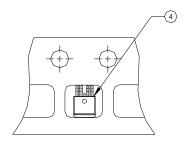
## D<sup>2</sup>Pak - 7 Pin Part Marking Information



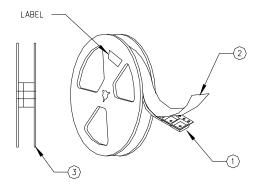
# D<sup>2</sup>Pak - 7 Pin Tape and Reel

NOTES, TAPE & REEL, LABELLING:

- 1. TAPE AND REEL.
  - 1.1 REEL SIZE 13 INCH DIAMETER.
  - 1.2 EACH REEL CONTAINING 800 DEVICES.
  - 1.3 THERE SHALL BE A MINIMUM OF 42 SEALED POCKETS CONTAINED IN THE LEADER AND A MINIMUM OF 15 SEALED POCKETS IN THE TRAILER.
  - 1.4 PEEL STRENGTH MUST CONFORM TO THE SPEC. NO. 71-9667.
  - 1.5 PART ORIENTATION SHALL BE AS SHOWN BELOW.
  - 1.6 REEL MAY CONTAIN A MAXIMUM OF TWO UNIQUE LOT CODE/DATE CODE COMBINATIONS.
    REWORKED REELS MAY CONTAIN A MAXIMUM OF THREE UNIQUE LOT CODE/DATE CODE COMBINATIONS.
    HOWEVER, THE LOT CODES AND DATE CODES WITH THEIR RESPECTIVE QUANTITIES SHALL APPEAR ON THE BAR CODE LABEL FOR THE AFFECTED REEL.



- 2. LABELLING (REEL AND SHIPPING BAG).
  - 2.1 CUST. PART NUMBER (BAR CODE): IRFXXXXSTRL-7P
  - 2.2 CUST. PART NUMBER (TEXT CODE): IRFXXXXSTRL-7P
  - 2.3 I.R. PART NUMBER: IRFXXXXSTRL-7P
  - 2.4 QUANTITY:
  - 2.5 VENDOR CODE; IR
  - 2.6 LOT CODE:
  - 2.7 DATE CODE:



Note: For the most current drawing please refer to IR website at: <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



### IMPORTANT NOTICE

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### **Revision History**

Date	Comments				
3/4/2015	Updated datasheet based on new IR corporate template .				
	• Updated part marking from "AUS3004-7P" to "AUFS3004-7P" on page 10.				